





## PRODUCT/PROCESS CHANGE NOTICE (PCN)

### ATTACHMENT I - PCN # : TB1910-01

**PCN Type:** Manufacturing Site - Alternate Test Location

**Data Sheet Change:** None

**Detail Of Change:**

This notification is to advise our customers that IDT is adding ASEK, Taiwan as an alternate facility for Test process for the selective products that are presently tested at IDT Penang, Malaysia facility.

This change will allow IDT the flexibility to ship from either facility and will provide the increased capacity, flexibility and shorter lead time to meet market demand.

There is no change in the Test processing flows. Load boards and test programs are the same at both qualified facilities. IDT has completed the electrical test correlation and based on the test results we do not anticipate any impact on device performance. The testing is fully compatible and transferrable between the test facilities with no change to the test coverage.

There is no change in the moisture sensitivity level (MSL).

If you require samples to conduct evaluations, please contact your local sales representative to acknowledge this PCN and request samples.

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**Qualification Information and Qualification Data:**
**Electrical Test Correlation Results**

Vehicle: 4RCD0232KC1ATG  
 Sample size: 510 electrically good units tested by handler  
 10 good and 10 reject units tested by handler

Description	Existing Test ( IDT Penang, Malaysia)	Alternate Test (ASEK, Taiwan)
Tester Platform	PS9G	PS9G
Loadboard	(DDR4_C0)-ATG253-Y-37-02A_305-PD-13-0928	(DDR4_C0)-ATG253-Y-37-02A_305-PD-13-0928
Test Program	CK_4RCD0232SCC1_EPSON_R11_REV08_SCD9064	CK_4RCD0232SCC1_EPSON_R11_REV08_SCD9064
Test Site	Quad Site	Quad Site
Test Temperature	105°C	105°C
Test Correlation Results	100%	100%
Number of Good Units Correlated	510 pcs	510 pcs
10 good units datalog correlation	Passed	Passed
10 reject units datalog correlation	Passed	Passed